

Search Notes

Application/Control No.

09/903,175

Examiner

Chieh M. Fan

Applicant(s)/Patent under
Reexamination

BAUM ET AL.

Art Unit

2638

SEARCHED

Class	Subclass	Date	Examiner
375	130 140-153 229	9/16/2005	CF
	260 267 295		
	299 316 346		
	347 348 349		
	350		
370	320 335 342		
	441		
455	59		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor Search	9/15/2005	CF
EAST IEEEExplore	9/15/2005	CF

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner